CT/FCT TEST PROBES

Spring-loaded test probe GKS-075 305 050 A 1000 LH

Item GKS-075-0885





- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles

General data

Product group ICT / FCT (in-circuit test and function test Sub-product group Standard stroke test probe GKS-075 LH long version Series Grid 1.91 mm [75 mil] Contacting from Pad, Female connector Magnetic Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No Compatible receptacle(s) KS-075 Min. temperature - 40 °C [- 104 °F] + 80 °C [+ 176 °F] Max. temperature RoHS-compliant RoHS-3;6c



Current load capacity / rated current 3 A
Typical resistance (Ri) <20 mOhm

Mechanical data

 Total length
 35.1 mm [1.38 in]

 Barrel diameter
 1.02 mm [.040 in]

 Maximum stroke
 6.35 mm [.25 in]

 Spring pre-load
 0.43 N [1.54 ozf]

 Collar height
 00

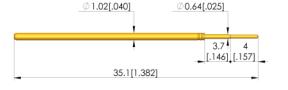
 Spring force at working stroke
 1 N [3.59 ozf]

 Recommended working stroke
 4.3 mm [.169 in]

Tip style data

Tip style 05 bullet-nosed (full radius)
Tip diameter 0.5 mm [.019 in]
Tip style surface A gold
Tip style material 3 CuBe



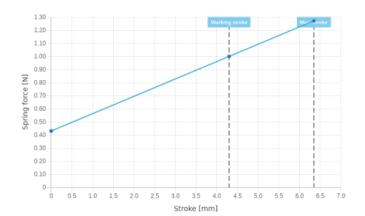




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Learn more about ICT/FCT Test probes

